

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 06618-424001	Application No. 09/532,461
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Marc A. Nicolet et al.	
		Filing Date March 22, 2000	Group Art Unit 1775

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AQ	Pisch et al., "Thermodynamic calculations offer insight in the stability of materials; the annealing behavior of amorphous Ru-Si-O and Ir-Si-O thin films", <u>Calphad</u> , Vol. 25, No. 4, pp. 639-644 (2001)
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

<b>Notice of References Cited</b>			Application No. <b>09/532,461</b>		Applicant(s) <b>Nicolet et al.</b>	
			Examiner <b>Stephen Stein</b>		Group Art Unit <b>1775</b>	
					Page 1 of 1	
<b>U.S. PATENT DOCUMENTS</b>						
		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
	A	5,851,896	12/1998	Summerfelt	438	396
	B	5,966,153	10/1999	Mitani et al.	347	62
	C					
	D					
	E					
	F					
	G					
	H					
	I					
	J					
	K					
	L					
	M					
<b>FOREIGN PATENT DOCUMENTS</b>						
		DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS
	N	JP405109585A	4/1993	Japan	Fujii et al.	---
	O	JP405147972A	6/1993	Japan	Fujii et al.	---
	P	JP405155620A	6/1993	Japan	Fujii et al.	----
	Q					
	R					
	S					
	T					
<b>NON-PATENT DOCUMENTS</b>						
		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)				DATE
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	V					
	W					
	X					

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1775

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A	6294,429 B1	9/2001	Tsu et al.	438	239
B					
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D					
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	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Country	Name	Classification <sup>2</sup>	
N						
O						
P						
Q						
R						
S						
T						

**NON-PATENT DOCUMENTS**

	Include, as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages
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<sup>\*</sup> A copy of this reference is not being furnished with this Office action. See MPEP § 707.05(a).<sup>1</sup> Dates in MM-YYYY format are publication dates.<sup>2</sup> Classifications may be U.S. or foreign.